

# Fluorescence yield for plastic scintillators after irradiation

Zishuo Yang<sup>a,\*</sup>, Alberto Belloni<sup>a</sup>, Sarah C. Eno<sup>a</sup>, Charles Hurlbut<sup>b</sup>,  
Geng-Yuan Jeng<sup>a</sup>, Kevin Pedro<sup>c</sup>, Yao Yao<sup>a</sup>, Adam Zeitlin<sup>a</sup>

<sup>a</sup>*Dept. Physics, U. Maryland, College Park MD 30742 USA*

<sup>b</sup>*Eljen Technology, 1300 W. Broadway, Sweetwater, TX 79556 USA*

<sup>c</sup>*Fermi National Accelerator Laboratory, Batavia, IL, USA*

---

## Abstract

The ratio of the fluorescence yield versus wavelength for plastic scintillators EJ-200 and EJ-260 before and after irradiation by a  $^{60}\text{Co}$  source for various doses and dose rates and for different concentrations of the primary and secondary dopant was measured. While the nominal dopant concentration gives the highest light output prior to irradiation, a higher concentration is found to be optimal for irradiated plastics.

*Keywords:* plastic scintillator, fluorescence, radiation hardness

---

## 1. Introduction

Organic scintillators such as polystyrene (PS) or polyvinyltoluene (PVT) containing wave-length shifting additives in solution have long been popular elements in detectors used in particle physics, nuclear physics, radiation safety, and  
5 health physics applications due to their high light output, low cost, fast response, and versatility of physical construction. Prolonged exposure of plastic scintillator to ionizing radiation, however, can result in damage: light self-absorption (yellowing) increases and the transfer efficiency of the initial excitation of the polymer to the dopants combined with the dopant's probability of radiative de-  
10 cay ("initial light output") can lessen. In this paper, we present measurements

---

\*Corresponding author

Email address: yangzs@terpmail.umd.edu (Zishuo Yang)

of the ratio of the light output before and after irradiation for two different types of plastic scintillator manufactured by Eljen corporation, EJ-200 (similar to BC-408 from Bicron corporation) and EJ-260 (similar to BC-428), before and after irradiation by a  $^{60}\text{Co}$  source for various doses and dose rates and for  
15 different concentrations of the primary and secondary dopant. Dose rate effects are of interest because materials testing is typically done at much higher dose rates than the scintillator will experience in use, because of the cost of reactor time. Dose rate effects may be responsible for the factor of three larger light loss with integrated luminosity in the CMS endcap calorimeter [? ? ] than  
20 expected based on high dose rate exposures using  $^{60}\text{Co}$  sources [? ? ].

The effect of dose and dose rate on radiation-induced yellowing have been the subject of many investigations. The results are summarized in [? ]. Dose rate effects during irradiation for the yellowing are well documented [? ? ? ? ? ? ? ]. The presence of oxygen plays an important role [? ]. The  
25 studies show that the penetration depth of oxygen into the substrate depends on the dose rate: at lower dose rates, oxygen penetrates more deeply [? ]. Because of the importance of the interaction of oxygen with radicals produced from the substrate during irradiation, this can lead to dose rate effects. Two different types of interactions occur. As discussed in [? ], the presence of oxygen  
30 increases the number of migration mechanisms for the radicals produced during irradiation. This allows the radicals produced during irradiation and that can create color centers which absorb light to migrate, find other radicals, and reform good chemical bonds. However, as discussed in [? ], Oxygen also interacts with the radicals produced during irradiation in a way that forms color centers. As  
35 shown in [? ], initially after a high dose rate irradiation, the damage when oxygen is present is less because of the increased migration. However, after allowing for an annealing (migration and annihilation of radicals, which can be encouraged through oxygen or heat) period after irradiation, the permanent damage is worse with oxygen [? ? ] due to the extra color centers formed in its  
40 presence. The amount of color centers that absorb at the wavelength emitted by the secondary dopant (permanent damage to the absorption length) seems

to be independent of the dose rate [? ]. However, as discussed in [? ], this may not be true for the light emitted by the substrate, in the deep UV.

Simulations based on oxygen diffusion have been shown to reproduce the  
45 time dependence of the induced attenuation length in scintillators based on  
PS and PMMA [? ]. Thus, immediately after irradiation at a high dose rate  
(Mrads/hr), the probability of absorption for visible light increases for wave-  
lengths shorter than around 600 nm (yellow) due to color centers that form in  
the substrate [? ]. At low dose rate, because the oxygen penetrates deeper, the  
50 initial damage is less. At very low dose rates, sufficient migration can occur  
even without oxygen, reducing the initial damage [? ].

Studies on the effect of radiation on the light yield are fewer than those  
on self-absorption. Several studies indicate that the damage is to the substrate  
and/or the transfer of its excitation to the dopants and not to the dopants them-  
55 selves. In an early study, Rosman and Zimmer [? ] found that the light output  
for organic scintillators based on PS versus dose is described, approximately  
and for relatively large dose rates, by a double exponential, with a small-dose  
component whose constant is approximately 100 Mrad. For a PS scintillator  
doped with 1.5% TPB, they also used UV light to illuminate the samples and  
60 found that this showed less reduction of light than excitation via charged par-  
ticles. Since PS is transparent to UV, this indicates that the TPB was not  
damaged, and instead the damage was either to the PS or the migration of  
excitation from the PS to the dopant. Subsequent studies ([? ? ? ]) came to  
a similar conclusions for liquid scintillators and for various plastic scintillators  
65 respectively.

If the damage is related to oxygen diffusion, a dose rate effect is expected.  
An interesting result, from 1996, is described in [? ]. They look at light  
output reduction for two PS-based scintillators (SCSN-38 and SCSN-81, from  
Kuraray) and a PVT-based scintillator (Bicron-499-35). Measurements were  
70 done as a function of time subsequent to irradiation, until the light output  
stabilized, using a  $^{241}\text{AM}$  alpha source. They find a reduction in post-recovery  
light output that depends linearly on the log of the dose rate for dose rates

ranging from 0.01 to 2 Mrad/hr. Note that the effect is not small: for a dose of 2 Mrad, the light loss is negligible for a dose rate of 2 Mrad/hr but 20% for a  
75 dose rate of 0.01 Mrad/hr for SCSN-81.

Two studies may be in contradiction to those described above. Two indicated very little damage to light output, and one indicated damage to the dopant.

In [? ], from 1993, SCSN-81, SCSN-23, and 3HF (based on PS) were studied at doses between 10 krad to 1 Mrad and three dose rates, 1.2 Mrad/hr, 0.01  
80 Mrad/h, using a long piece of plastic and a  $^{90}\text{Sr}$  beta source. They also looked at 0.0003 Mrad/hr with doses of 1.3 and 0.57 Mrad. They saw a small decrease in light output after recovery, indicating very little effect on the light yield. In another study, by Bross, Pla-Dalmau, *et al.* from 1991 [? ], the authors looked at light output for various primary (DAT, MOPOM, OLIGO408, OLIGO415A)  
85 and secondary (BBQ, K27, DMPOPOP, 3HF) dopants in PS for a dose of 10 Mrad accumulated with a relatively high dose rate (0.4 Mrad/h). They looked at this for 2 different concentrations of the secondary dopant. They optimized the concentration of the first dopant using the light output before irradiation. They found no change to the intrinsic light output, indicating at high dose rates  
90 the dopants were not damaged by this large dose. Perhaps the damage was not seen in the first due to the relatively low doses and in the second due to the high dose rate.

In [? ], decreased light output for a plastic scintillator from Kuraray, SCSN-38, which is based on PS with b-PBD primary and BDB secondary dopants, was  
95 seen. The main absorption wavelengths for PS typically range between between 230 to 260 nm, for the primary dopant b-PBD between 270 to 330 nm, and for the wavelength shifting dopant BDB between 310 to 400 nm. They found that light loss was much stronger in the presence of oxygen. Note that while oxygen plays a beneficial role in regards to annealing of induced absorption length at  
100 the end of radiation, it plays a detrimental role in regards to light output. They also found the light output loss was independent of the wavelength of the light that was used to excite the scintillator when it was varied between 230 and 400 nm. From this they conclude that the damage is due to destruction of the

second fluor. This is different than what was found in the other studies, which  
105 indicated that damage to the dopants was small and that damage was mostly to  
the substrate, although different dopants were used in the studies. By looking  
at the damage as a function of the thickness of the scintillator, they concluded  
that the BDB molecules are mainly destroyed near the surface, which lends  
support to a mechanism involving oxygen diffusion.

110 If there is damage, and the damage is to the transfer mechanism, increasing  
the dopant concentration could help. In [?] (perhaps better documented in  
[?]), the authors show that for a PS fiber with primary dopant of PTP and  
secondary dopant of 3HF, increasing the dopant concentration from nominal to  
20 times nominal continuously increases the light output after 100 Mrad (dose  
115 rate unknown).

In [?], the radiation resistance of BC-408 (from Bicon Corporation) was  
studied for different concentrations of the dopant from half to 3/2 the nominal  
concentration. The study was done at very high dose rate (36 Mrad/hr) and a  
total dose of 3 Mrad. They saw that varying the concentration of the secondary  
120 fluor did not affect the output as studied with a  $^{207}\text{Bi}$  electron source. They  
found decreasing the secondary dopant made it less rad hard, but increasing did  
not help. Also, based on studies comparing PVX to PS and PVT, the authors  
of [?] also concluded that increasing the concentration of the primary dopant  
might reduce radiation damage.

125 In order to understand the relative role of destruction of the dopants ver-  
sus damage to the substrate for modern scintillating plastics, we have studied  
the light output for two plastic scintillators, EJ-200 and EJ-260, varying the  
concentration of the dopants, for different total doses and dose rates.

## 2. Measurements

130 Both EJ-200 and EJ-260 use PVT as a substrate. EJ-200 has a light output  
that is 60% of anthracene and a wavelength of maximum emission of 435 nm  
(blue). EJ-260 also has a light output that is 60% of anthracene but a wave-

length of maximum emission of 490 nm (green). Eljen prepared scintillator bars with dimensions of 1x1x5cm. For the EJ-200, bars were made with concentration of the primary scintillation dopant at 0.5, 1.0, 1.5, and 2.0 that of the standard concentration. For the EJ-260, bars with made with concentrations of the primary (x) and secondary (p) dopant of 1x1p, 1x2p, 1x4p, 2x1p, 4x1p, 2x2p, and 4x4p. The fluorescence output was measured using a fluoromax-4 fluorometer by Horiba Scientific using a right-angle configuration and an excitation wavelength of xx nm. For the absorption measurements, a xx by xx was used. Air was used as the reference. In [? ], the integration of the fluorescence spectra was shown to reproduce the results using a  $^{207}\text{Bi}$  source to within a few percent for most dopants.

Radiations were done using a  $^{60}\text{Co}$  source at the University of Maryland with an activity of xxx. The dose was measured using i don't know

Figure 4 shows the spectra for EJ-200 with nominal doping before irradiation and after 30 Mrad at 1 Mrad/hr and after 50 Mrad at 1 Mrad/hr.



Figure 1: Emission spectrum for EJ-200 at nominal doping before irradiation, after 30 Mrad at 1 Mrad/hr and after 50 Mrad at 1 Mrad/hr.

Table 1 shows the ratio of the light output at **xxx nm** for the EJ-200 to that before irradiation for different doses, dose rates, and dopant concentrations. Figure 2 shows the ratio of the light output at **xxx nm** for the EJ-200 to that before irradiation as a function of dose rate for several total doses.

Table 1: Ratio of average light output at **xxx nm** to that before irradiation for EJ-200 scintillator. For the concentrations of the dopants, NpMs refers to N times the default concentration of primary and M times the default concentration of the secondary dopant the commercial version of the product.

Dose (Mrad)	Dose rate (Mrad/hr)	light output ratio for dopings			
		1p1s	0.5p1s	1.5p1s	2.0p1s
0	—	1.0	<b>xx</b>	<b>xx</b>	<b>xx</b>
2	0.1	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>
2	0.3	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>
2	1.0	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>
4	0.1	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>
4	0.3	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>
4	1.0	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>
10	0.3	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>
10	1.0	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>
30	1.0	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>
50	1.0	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>

Table 2 shows the ratio of the light output at **xxx nm** for EJ-260 to that before irradiation for different doses, dose rates, and dopant concentrations. Figure 3 shows the ratio of the light output at **xxx nm** for EJ-260 to that before irradiation as a function of dose rate for several total doses.

### 3. Interpretation

If this dose rate effect is due to oxygen diffusion, then we expect it to be governed by the diffusion equation. Since the oxygen diffusion depth is greater at lower dose rates, we expect the damage for the same dose at different dose



Figure 2: Ratio average light output for EJ-260 at **xxx nm** to that before irradiation versus dose rate for several total doses.

rates to increase up to the point where the dose rate is low enough that oxygen permeates the entire sample for particles such as minimum ionizing particles that transverse the sample. For particles such as alphas and low energy  $\beta$ s, the saturation should occur sooner. The dose rate effect should plateau at this point. Specifically, we predict (following [? ]) that the light output reduction should depend on both the dose and the dose rate as:

$$L(R, D) = 1 - [f(D)Z(R) + a(D)(1 - Z(R))]$$

where L is the % light yield, D is the dose, R is the dose rate, Z(R) is the fraction of the scintillator containing oxygen and is given by

$$Z(R) = \min(\frac{2z_0(R)}{d}, 1)$$

where d is the thickness of the scintillator and  $z_0$  gives the depth of scintillator penetrated by oxygen,  $a(D)$  is related to the fraction of quenching in the part of the scintillator containing oxygen and is given by  $1 - e^{-a_0 D}$ , and  $f(D)$  is related



Table 2: Ratio of light output at **xxx nm** to that before irradiation for EJ-260 scintillator. For the concentrations of the dopants, NpMs refers to N times the default concentration of primary and M times the default concentration of the secondary dopant the commercial version of the product.

Dose (Mrad)	Dose rate (Mrad/hr)	light output ratio for dopings						
		1p1s	2p1s	4p1s	1p2s	1p4s	2p2s	4p4s
0	—	1.0	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>
2	0.1	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>
2	0.3	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>
2	1.0	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>
4	0.1	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>
4	0.3	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>
4	1.0	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>
10	0.3	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>
10	1.0	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>
30	1.0	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>
50	1.0	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>	<b>xx</b>

to the fraction of quenching in the part of the scintillator not containing oxygen and is given by  $1 - e^{-f_0 D}$ . The diffusion depth  $z_0(R)$  is given by diffusion theory as

$$z_0(R) = \sqrt{\gamma/R}$$

where  $\gamma$  is a property of the substrate and the radicals that are dissolved in that substrate during the diffusion process. The value for  $\gamma$  depends on the material, oxygen pressure, radical concentration (which is proportional to the dose) and temperature. The minimization in  $Z(R)$  occurs because the fraction of scintillator containing oxygen can not exceed one. Note that this equation assumes the temperature and the surrounding atmosphere is held constant, as this can affect diffusion.



Figure 3: Ratio average light output for EJ-260 at xxx nm to that before irradiation versus dose rate for several total doses.

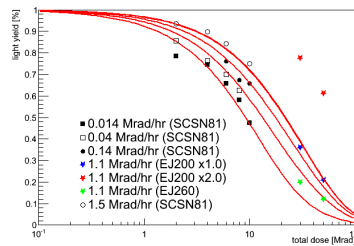


Figure 4: Comparison of results with data from Biagtan *et al.* [?] ]

#### 4. Conclusions

#### 165 5. Acknowledgments

The authors would like to thank Neil Blough and Anna Pla-Dalmau for advice on taking fluorescence measurements, and Blough for the use of his machine.

We thank Saint Anselm’s Abbey school for use of their 3D printer. The authors would like to thank various people at the University of Maryland’s Nuclear Reactor and Radiation Facilities group for assistance with the irradiations. This  
170 work was supported in part by U.S. Department of Energy Grant DESC0010072.

## References